

<b>Notice of References Cited</b>	Application/Control No. 10/674,159		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner SEAN MCGARRY		Art Unit 1635	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,199,109	04-2007	Pal et al.	514/44A
*	B	US-7,304,042	12-2007	Pal et al.	514/44A
*	C	US-7,288,531	10-2007	Pal et al.	514/44A
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Elbashir et al., Methods Vol.26:199-213, 2002.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.